

Prospective Data
Insulated Gate Bi-Polar Transistor
Type T0600TA45A

Absolute Maximum Ratings

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V_{CES}	Collector – emitter voltage	4500	V
$V_{DC\ link}$	Permanent DC voltage for 100 FIT failure rate.	2800	V
V_{GES}	Peak gate – emitter voltage	±20	V

	RATINGS	MAXIMUM LIMITS	UNITS
$I_{C(DC)}$	Continuous DC collector current, IGBT (Note 3)	776	A
I_{CRM}	Repetitive peak collector current, $t_p=1ms$, IGBT	1000	A
$I_{F(DC)}$	Continuous DC forward current, Diode (note 2 & 4)	637	A
I_{FRM}	Repetitive peak forward current, $t_p=1ms$, Diode	1000	A
P_{MAX}	Maximum power dissipation, IGBT (note 3)	6.2	kW
$(di/dt)_{cr}$	Critical diode di/dt (note 4)	2000	A/μs
T_j	Operating temperature range.	-40 to +125	°C
T_{stg}	Storage temperature range.	-40 to +125	°C

Notes: -

- 1) Unless otherwise indicated $T_j = 125^\circ\text{C}$.
- 2) $T_{sink} = 55^\circ\text{C}$, double side cooled.
- 3) $T_{sink} = 25^\circ\text{C}$, double side cooled.
- 4) Maximum commutation loop inductance 1μH.

Characteristics

IGBT Characteristics

	PARAMETER	MIN	TYP	MAX	TEST CONDITIONS	UNITS
V _{CE(sat)}	Collector – emitter saturation voltage	-	3.5	3.9	I _C = 600A, V _{GE} = 15V, T _J = 25°C	V
		-	4.7	5.1	I _C = 600A, V _{GE} = 15V	V
V _{T0}	Threshold voltage	-	-	1.93	Current range: 200 – 600A	V
r _T	Slope resistance	-	-	4.62		mΩ
V _{GE(TH)}	Gate threshold voltage	4.8	5.4	5.8	V _{CE} = V _{GE} , I _C = 200mA	V
I _{CES}	Collector – emitter cut-off current	-	15	40	V _{CE} = V _{CES} , V _{GE} = 0V	mA
I _{GES}	Gate leakage current	-	-	±120	V _{GE} = ±20V	μA
C _{ies}	Input capacitance	-	100	-	V _{CE} = 25V, V _{GE} = 0V, f = 1MHz	nF
t _{d(on)}	Turn-on delay time	-	1.6	-	I _C = 600A, V _{CE} = 0.5V _{CES} , V _{GE} = ±15V, R _{g(ON)} = 6.5Ω, R _{g(OFF)} = 4Ω,	μs
t _{r(l)}	Rise time	-	2.1	-		μs
Q _{g(on)}	Turn-on gate charge	-	-	50		μC
E _{on}	Turn-on energy	-	2.0	-		J
t _{d(off)}	Turn-off delay time	-	1.2	-		μs
t _f	Fall time	-	1.2	-		μs
Q _{g(off)}	Turn-off gate charge	-	-	60		μC
E _{off}	Turn-off energy	-	1.9	-		J

Diode Characteristics

	PARAMETER	MIN	TYP	MAX	TEST CONDITIONS	UNITS
V _F	Forward voltage	-	3.1	3.5	I _F = 600A, T _J = 25°C	V
		-	3.6	4.0	I _F = 600A	V
V _{T0}	Threshold voltage	-	-	1.625	Current range 200-600A	V
r _T	Slope resistance	-	-	3.284		mΩ
I _{rm}	Peak reverse recovery current	-	1190	-	I _F = 600A, V _{GE} = ±15V, di/dt=1500A/μs	A
Q _{rr}	Recovered charge, 50% chord	-	540	-		μC
t _{rr}	Reverse recovery time, 50% chord	-	0.78	-		μs
E _r	Reverse recovery energy	-	0.97	-		J

Thermal Characteristics

	PARAMETER	MIN	TYP	MAX	TEST CONDITIONS	UNITS
R _{thJK}	Thermal resistance junction to sink, IGBT	-	-	16	Double side cooled	K/kW
		-	-	24	Collector side cooled	K/kW
		-	-	48	Emitter side cooled	K/kW
R _{thJK}	Thermal resistance junction to sink, Diode	-	-	39	Double side cooled	K/kW
		-	-	58	Cathode side cooled	K/kW
		-	-	118	Anode side cooled	K/kW
F	Mounting force	15	20	25	Note 2	kN
W _t	Weight	-	1.2	-		kg

Notes:-

- 1) Unless otherwise indicated T_J=125°C.
- 2) For other clamp forces, please consult factory

Curves

Figure 1 – Typical collector-emitter saturation voltage characteristics

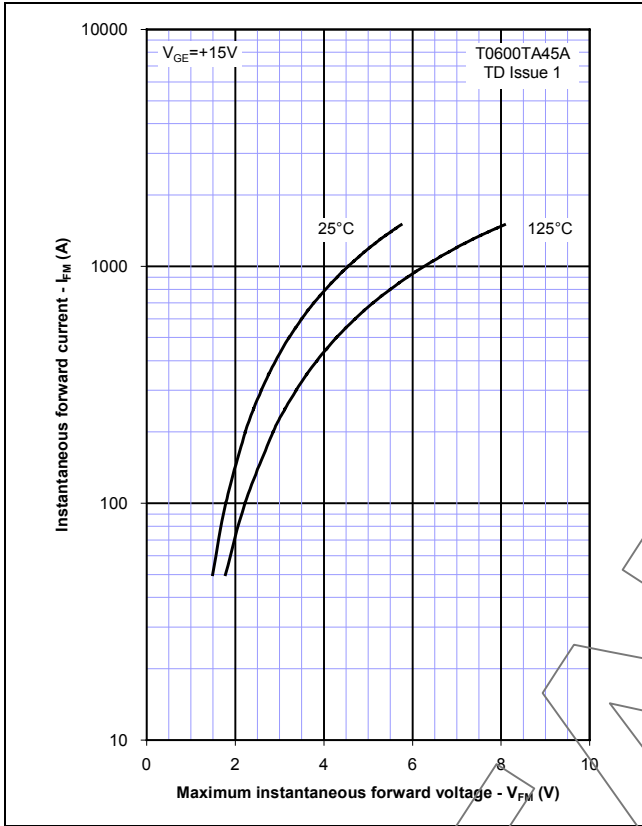


Figure 2 – Typical output characteristic

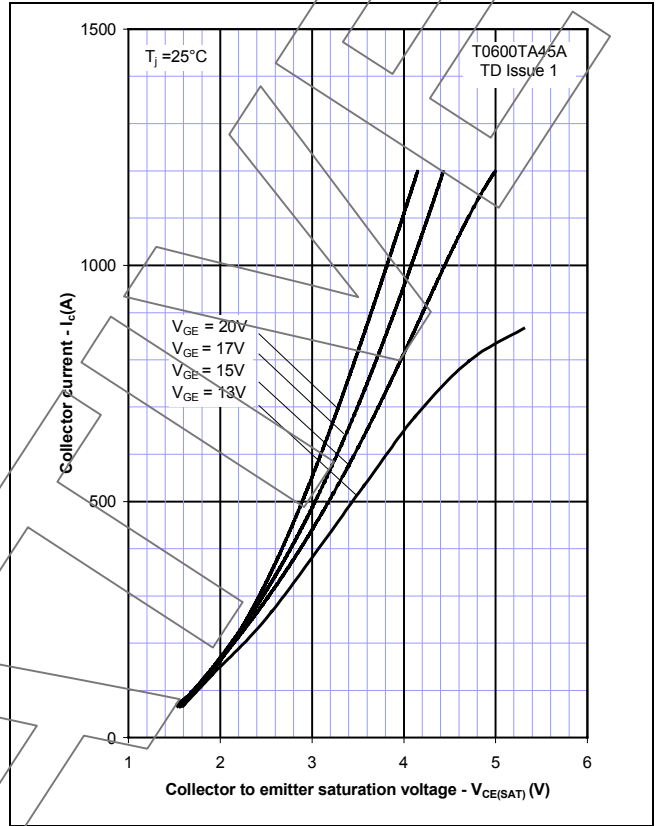


Figure 3 – Typical output characteristic

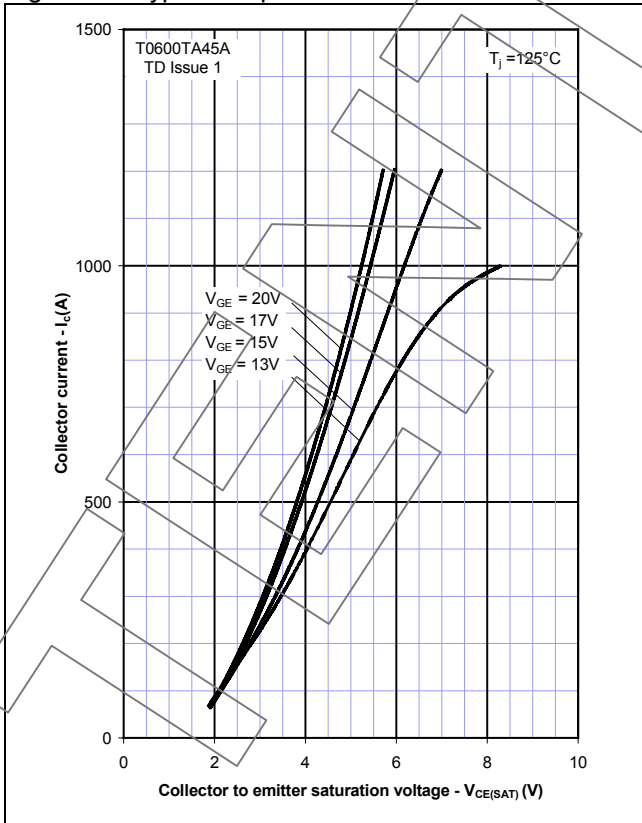


Figure 4 – Typical turn-on gate charge

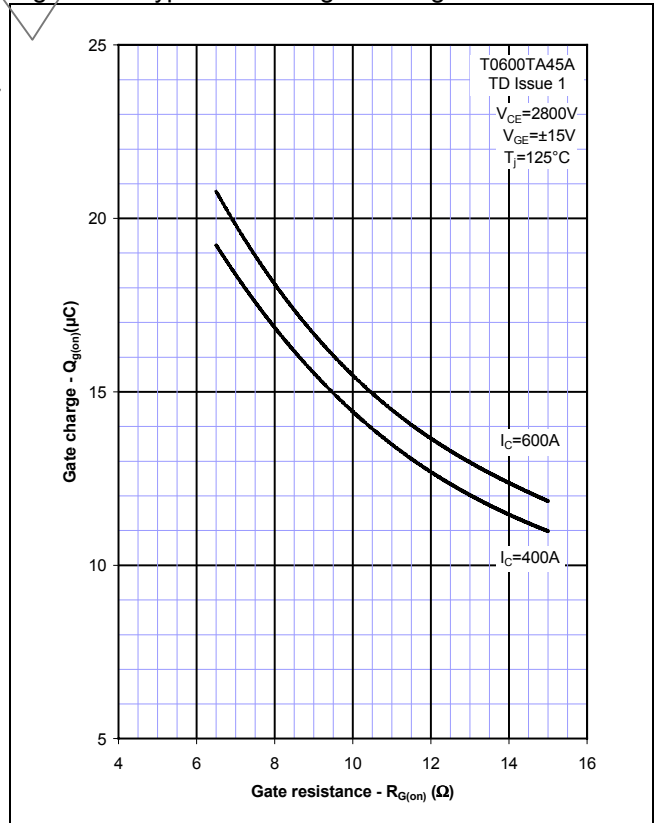


Figure 5 – Typical turn-off gate charge

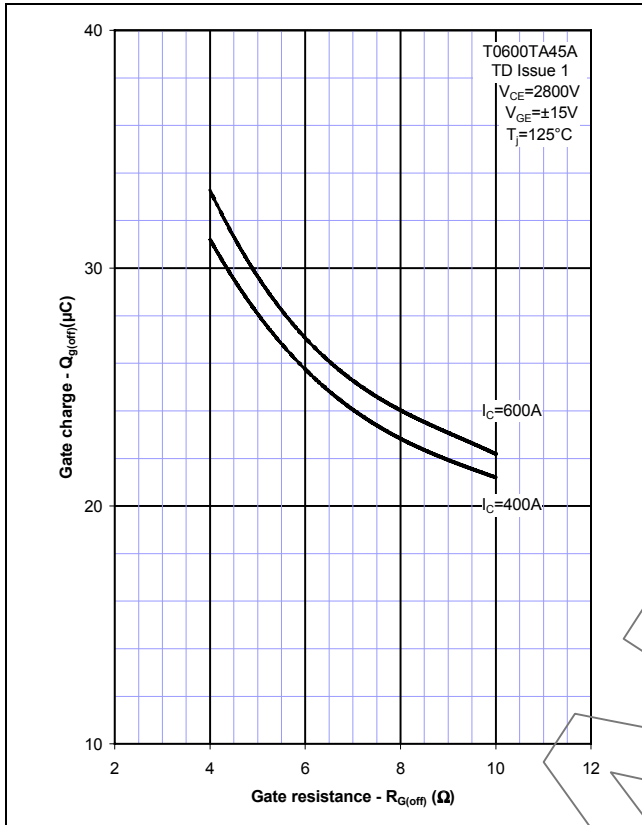


Figure 6 – Typical turn-on delay time vs gate resistance

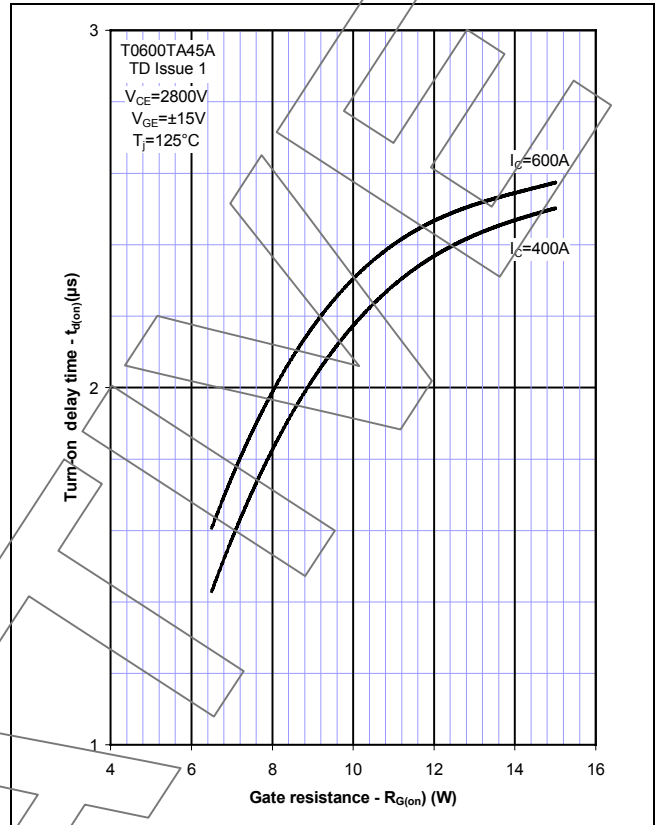


Figure 7 – Typical turn-off delay time vs. gate resistance

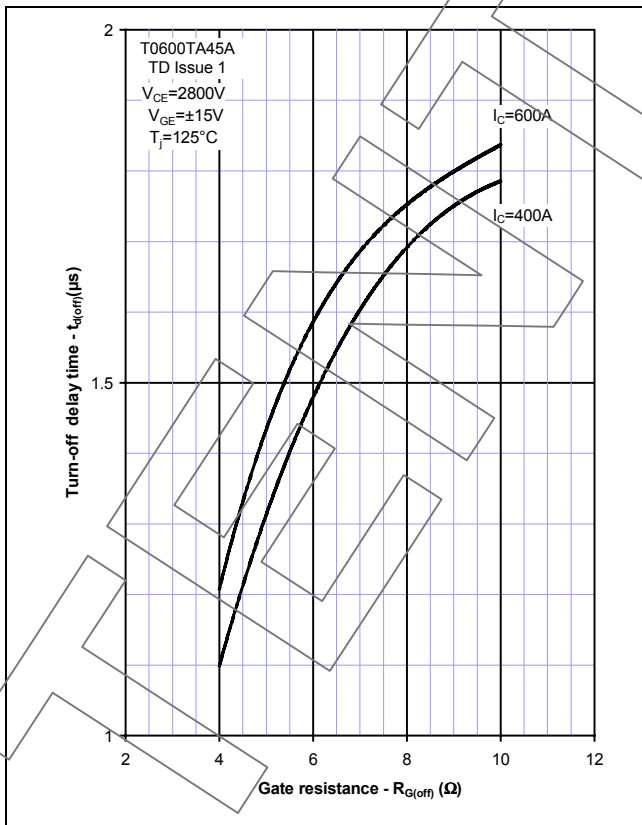


Figure 8 – Typical turn-on energy vs. collector current

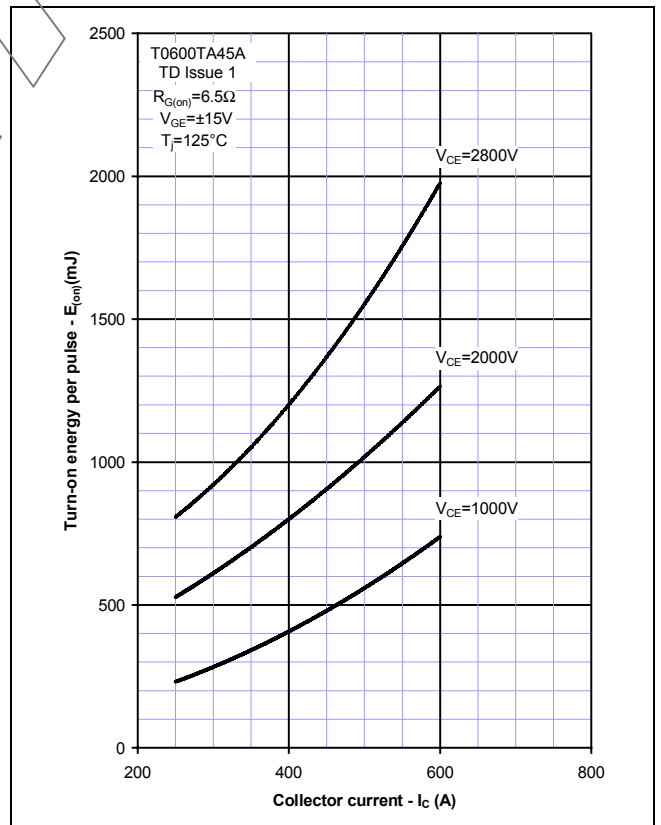


Figure 9 – Typical turn-on energy vs. di/dt

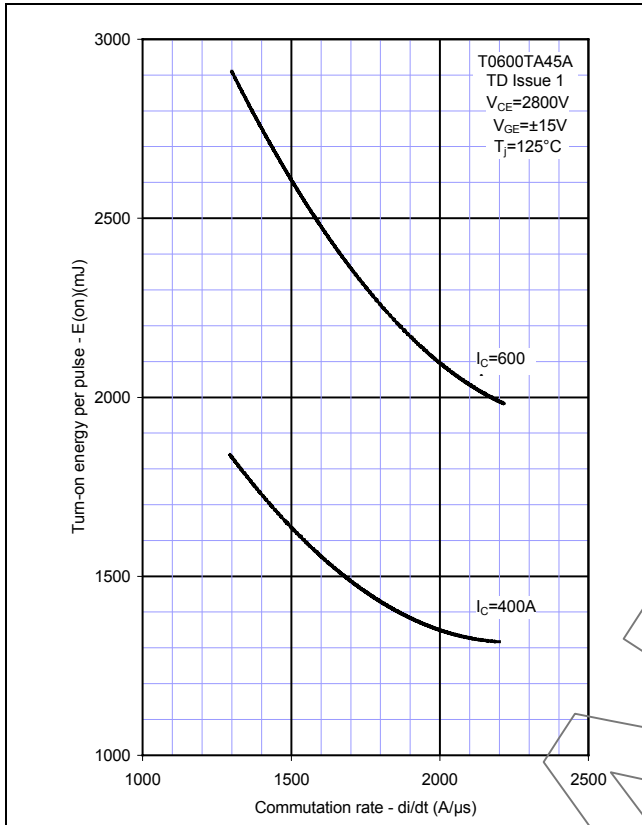


Figure 10 – Typical turn-off energy vs. collector current

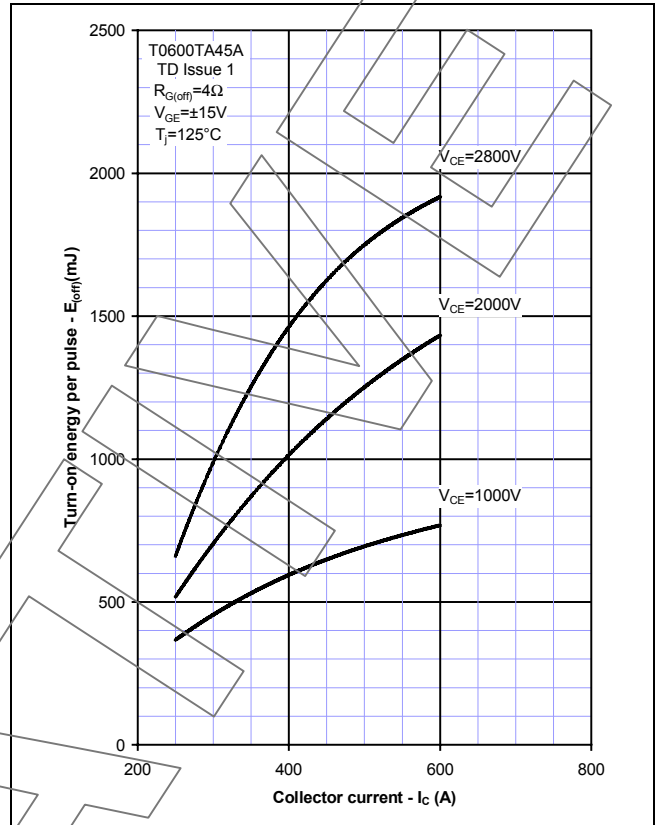


Figure 11 – Turn-off energy vs voltage

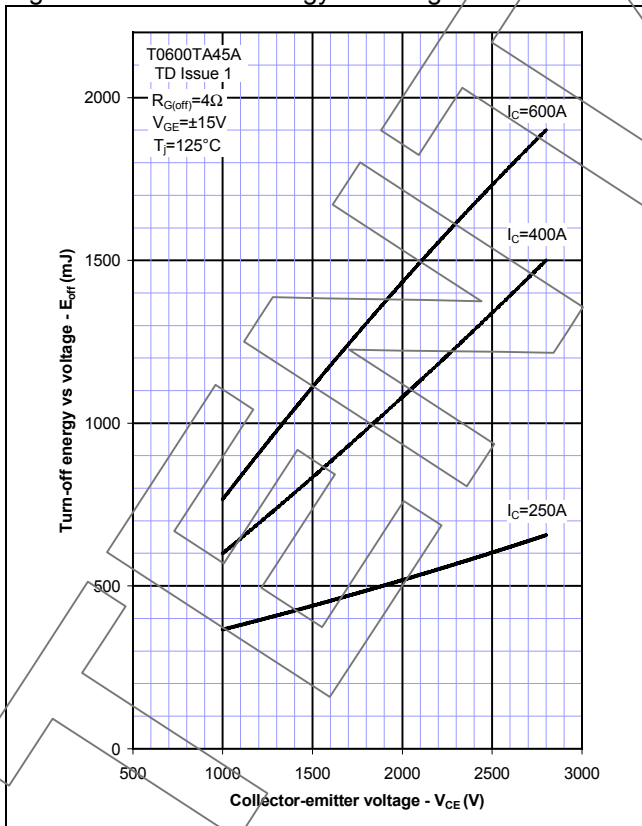


Figure 12 – Safe operating area

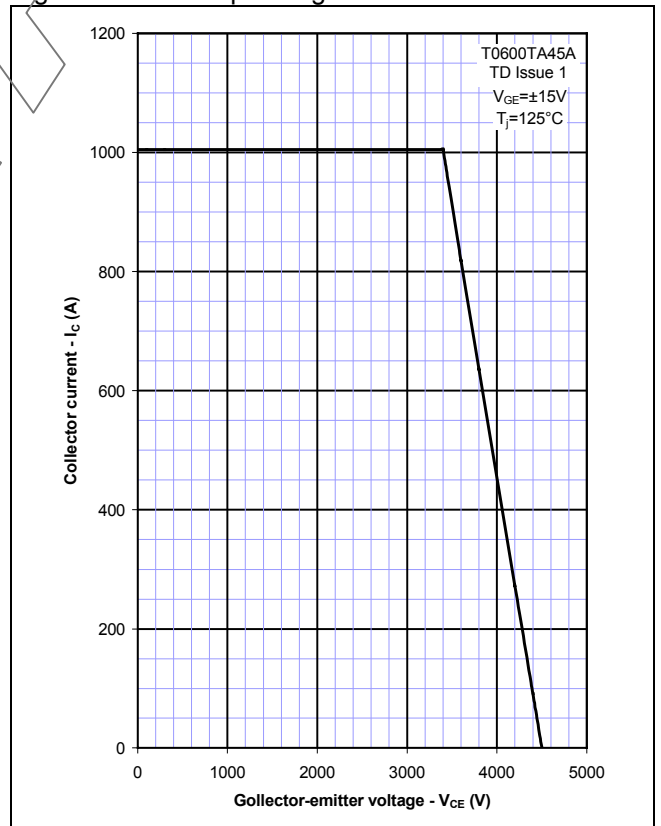


Figure 13 – Typical diode forward characteristic

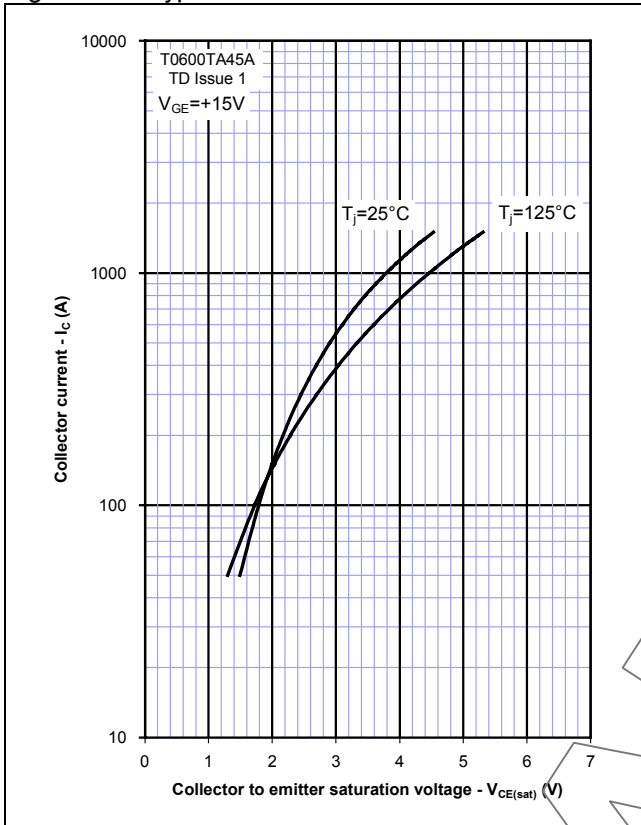


Figure 14 – Typical recovered charge

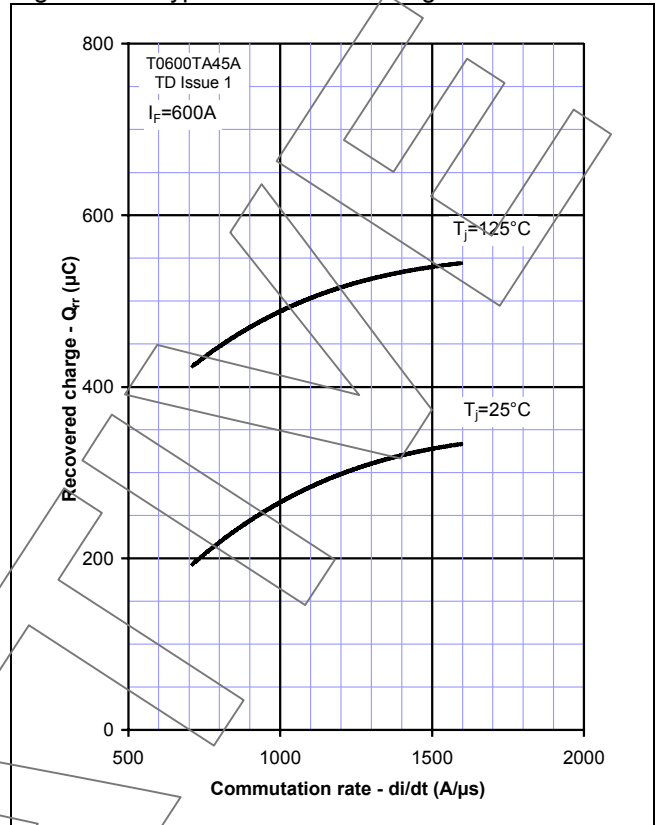


Figure 15 – Typical reverse recovery current

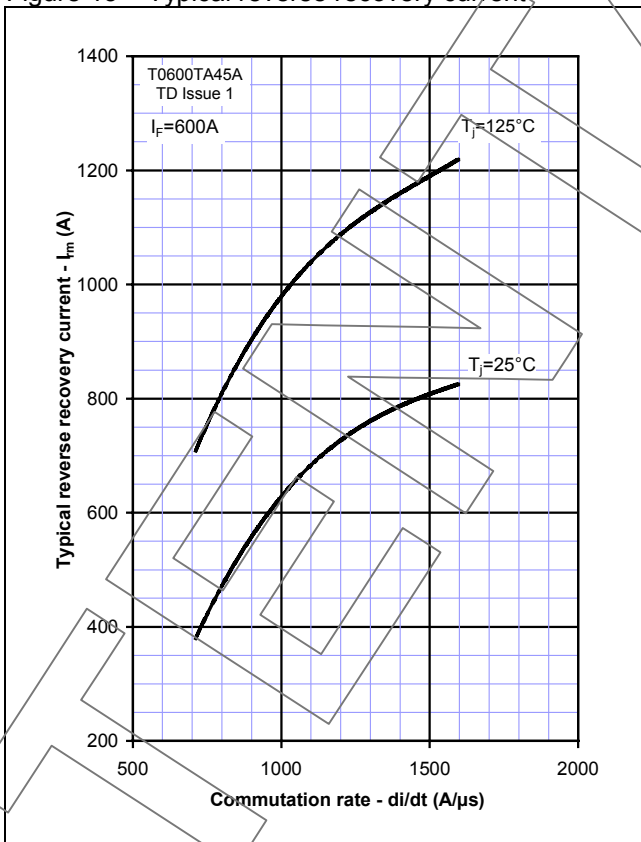


Figure 16 – Typical reverse recovery time

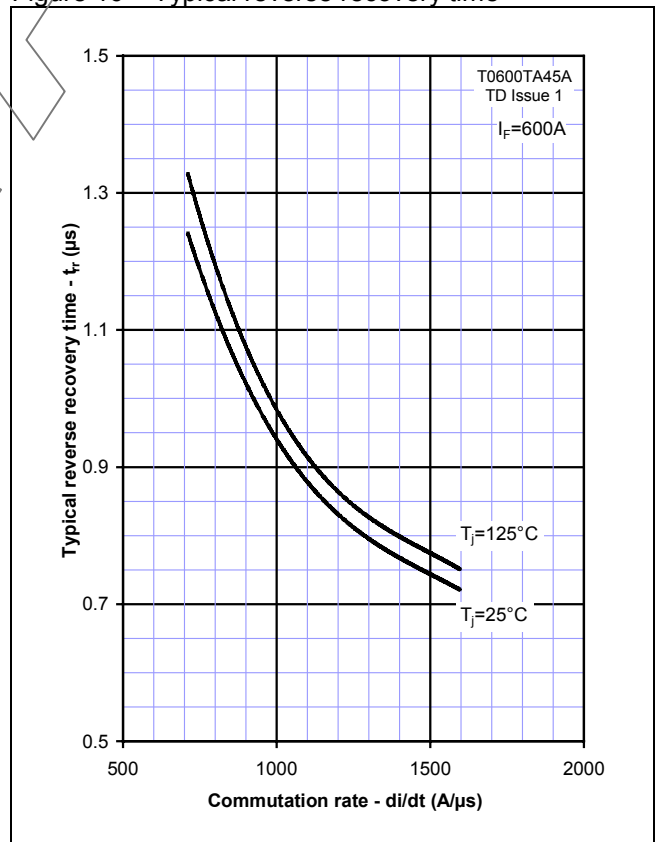


Figure 17 – Transient thermal impedance (IGBT)

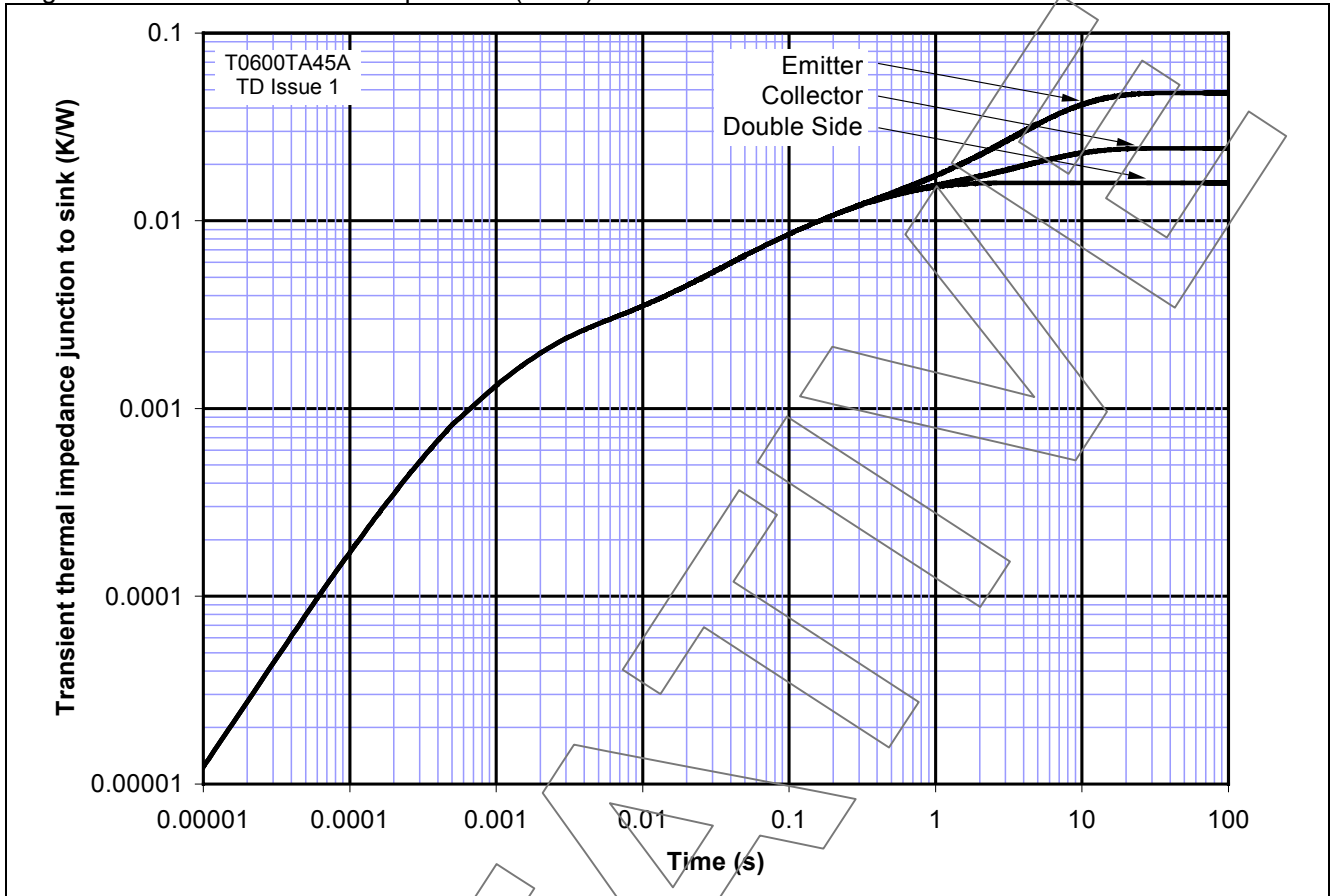
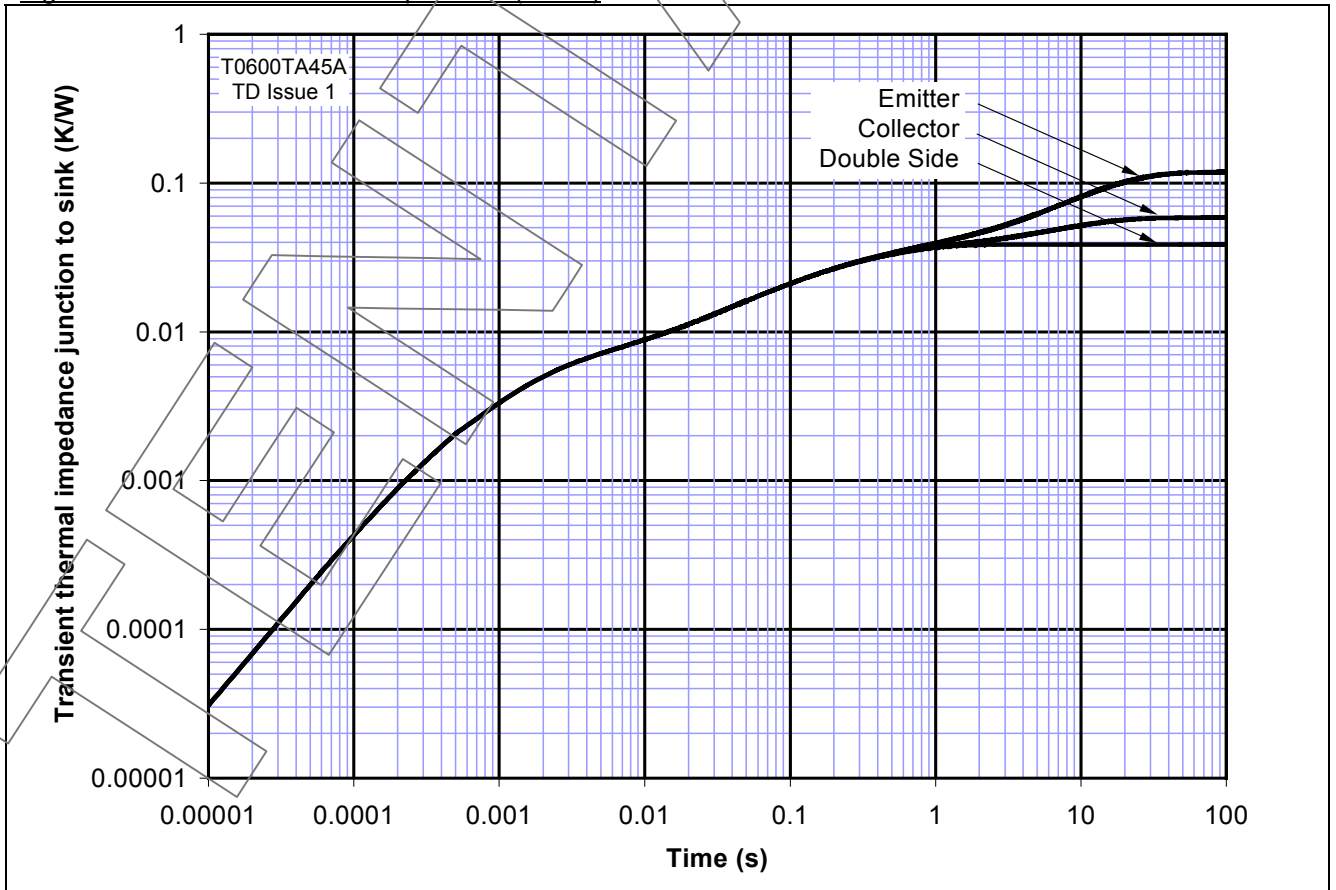
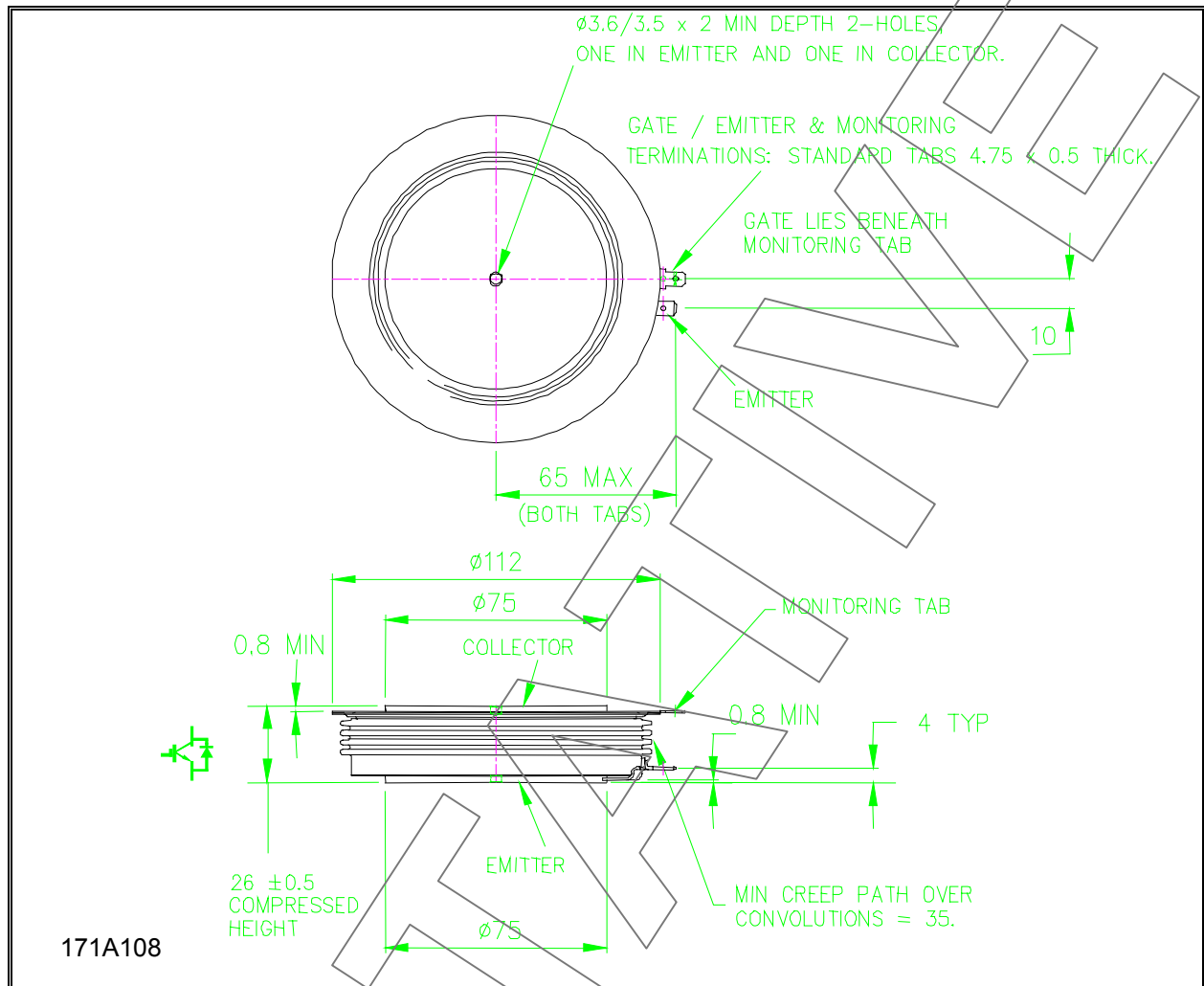


Figure 18 – Transient thermal impedance (Diode)



Outline Drawing & Ordering Information



ORDERING INFORMATION

(Please quote 10 digit code as below)

T0600 Fixed type Code	TA Fixed Outline Code	45 Voltage Grade 4500	A Fixed format code
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Typical order code: T0600TA45A (V_{CE5} = 4500V)

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